Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/824,288	SHTEIN ET AL.
Examiner	Art Unit
Matthew W. Such	2891

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SE (INCLUDIN)	ARCH NOT	ES STRATEGY)
		DATE	EXMR
None		9/1/2006	MWS